

Substitute for form 1449A/PTO & 1449B/PTO			
SECOND INFORMATION DISCLOSURE STATEMENT BY APPLICANT			
(use as many sheets as necessary)			
Sheet	1	of	1
		Com.	ee if Known
		Application Number	10/081,234
		Filing Date	February 25, 2002
		First Named Inventor	Hirofumi TOTSUKA et al. JAN 03 2007
		Examiner Name	Unassigned
		Attorney Docket Number	027260-515

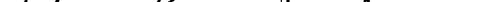
U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

NON-PATENT LITERATURE DOCUMENTS

Examiner Initials	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
<i>QZW</i>	N. Mukherjee, et al., "Built-In Self-Test: A Complete Test Solution for Telecommunication Systems", IEEE Communications Magazine, Vol. 37, No. 6, June 1999, pages 72-78
<i>QZW</i>	M. Gagnon, et al., "Optical Communication Channel Test Using Bist Approaches", Proceedings of the International Test Conference, ITC 1997, IEEE, Vol. Conf. 28, November 1, 1997, pages 626-635

VA 49529.1

Examiner Signature		Date Considered	1/23/2007
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with M.P.E.P. § 608. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.